Application/Control No. Applicant(s)/Patent Under Reexamination 09/825,889 WAKISAKA ET AL. **Notice of References Cited** Examiner Art Unit Page 1 of 1 2861 Hai C Pham **U.S. PATENT DOCUMENTS** Date Document Number Classification Name Country Code-Number-Kind Code MM-YYYY US-US-В US-С US-D US-Ε F US-US-G US-US-1 US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS Document Number Country Code-Number-Kind Code Date Name Classification Country MM-YYYY B41J 2/44 04-2000 Japan Kondo et al. JP 2000-103116 N 0 Р Q R s Т NON-PATENT DOCUMENTS Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) W

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